

Notice of References Cited	Application/Control No. 10/526,065	Applicant(s)/Patent Under Reexamination TERAHARA ET AL.	
	Examiner Suezu Ellis	Art Unit 1615	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0102290	08-2002	HIRANO et al.	424/448
	B	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	CA 2428181A1	05-2002	Canadian Patent	TERAHARA et al.	
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NON-PATENT DOCUMENTS

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